FORM PTO-1449

## U.S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE

TTORNEY DOCKET NO.	APPLICATION NO
1567.1022	AFFEICATION NO
IRST MAMED INVENTOR	

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

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IRST NAMED INVENTOR	.00
Soo seok CHOI, et al.	75.s
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**U.S. PATENT DOCUMENTS** 

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EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE		
RAW	AA	5,460,905	10/24/1995	Skotheim					
	АВ	5,441,831	8/15/1995	Okamoto et al.					
	AC	5,162,175	11/10/1992	Visco et al.					
	AD	4,833,048	5/23/1989	Dejonghe et al.					
	AE	4,917,974	4/17/1990	De Jonghe et al.					
	AF	5,814,420	9/29/1998	Chu					
	AG	5,919,587	7/6/1999	Mukherjee et al.					
	АН	5,609,720	3/11/1997	Lenz et al.					

FOREIGN PATENT DOCUMENTS

			DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLAT YES N	TION NO
VA	$\mathcal{W}$	Al	WO 99/33127	7/1/1999	WIPO				
		AJ	09-147868	6/6/1997	Japan			Abstract only	
		AK	WO 99/33131	7/1/1999	WIPO				
	y	AL	WO 99/33125	7/1/1999	WIPO				

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

RM	AM	Levillain, E., et al., "Polysulfides in dimethylformamide: only the redox couples S //S² are involved", Journal of Electroanalytical Chemistry 440, 1997, pp. 243-250.
Appro	AN	Oyama, N., et al., "Dimercaptan-polyaniline composite electrodes for lithium batteries with high energy density", Nature International Weekly Journal of Science, Vol. 373, No. 6515, February 1995, pp. 598-600.

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EXAMINER	RM	DATE CONSIDERED 12/01/03	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 2 of 2

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DAM	ВМ	Levillain, E., et	al. "On the und	lerstanding of the reduction nemistry 420, 1997, pp. 16	on of sulfur (S	S <sub>8</sub> ) in dime	thylforr	namide	(DMF),
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